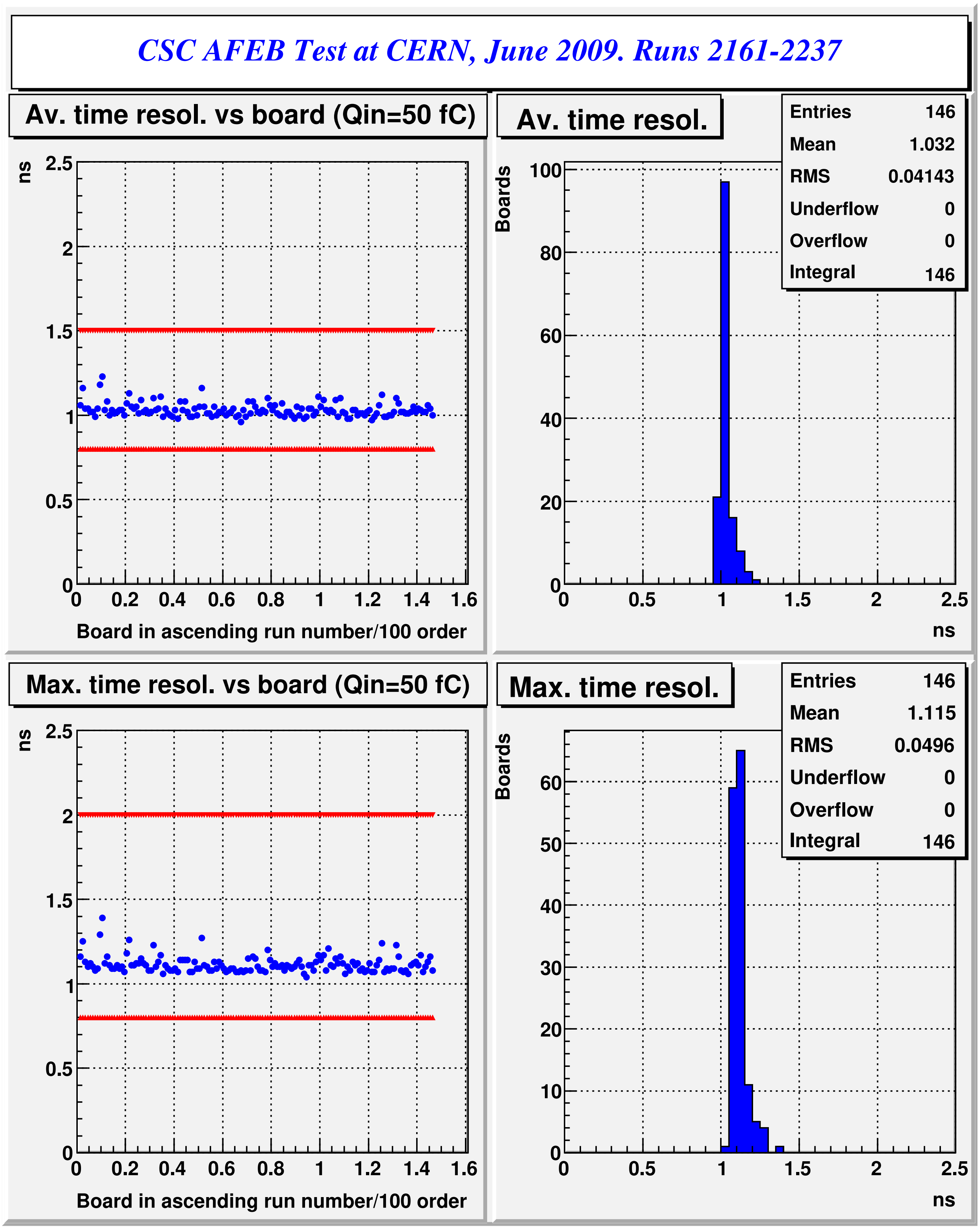
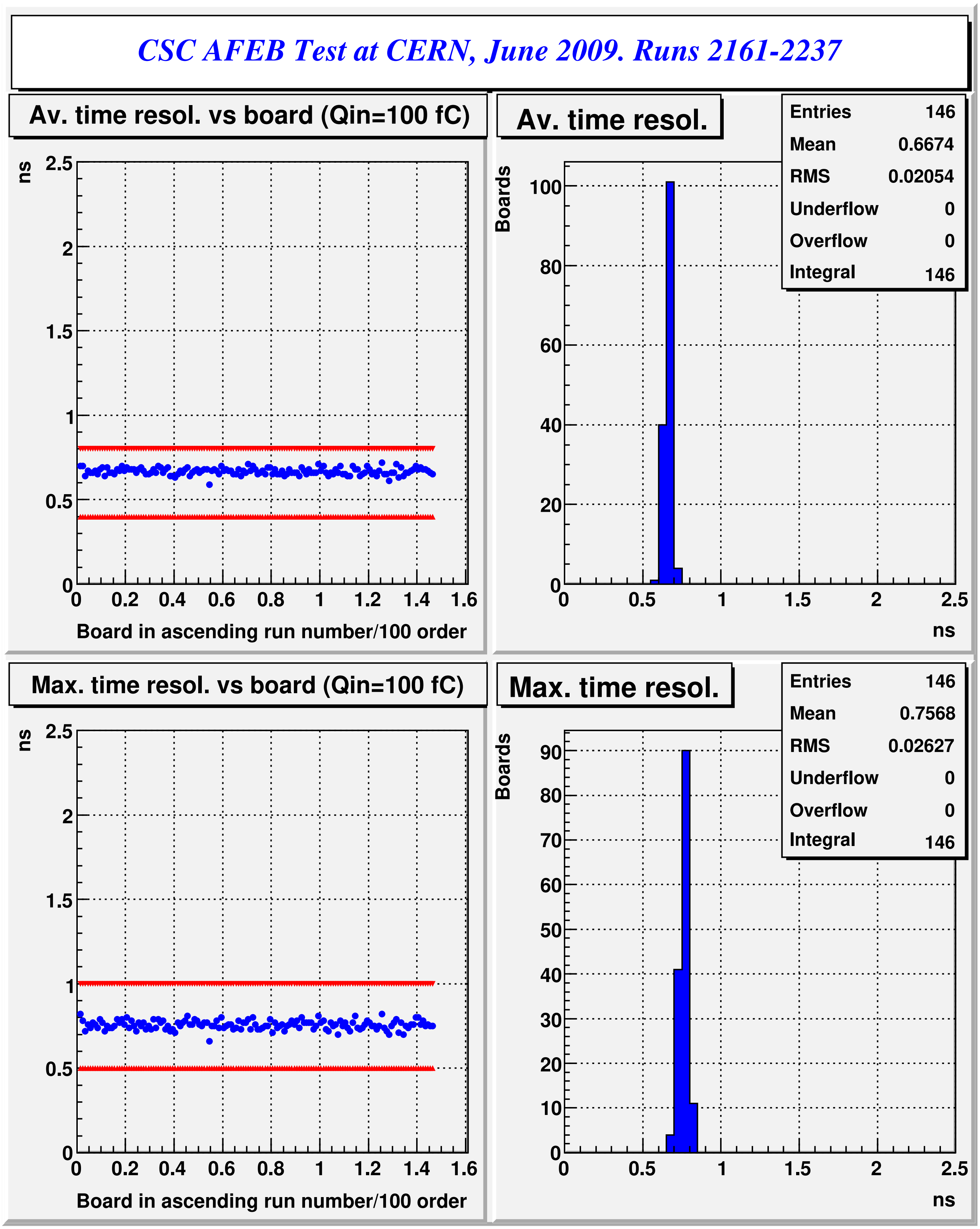
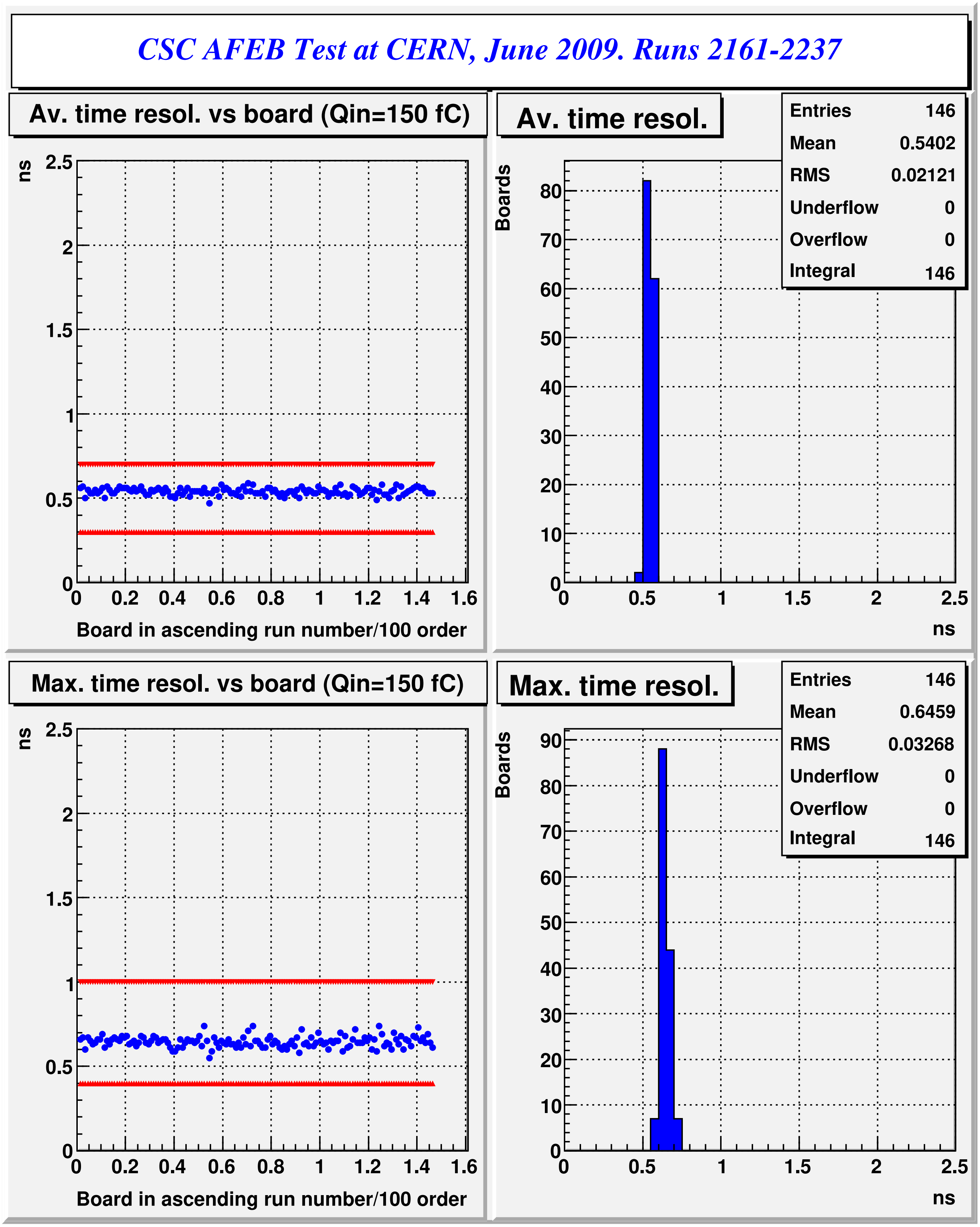

CSC AFEB Test at CERN, June 2009. Runs 2161-2237
Av. time resol. vs board (Qin=50 fC)
ns
Board in ascending run number/100 order
Av. time resol.
Boards
ns
Entries 146
Mean 1.032
RMS 0.04143
Underflow 0
Overflow 0
Integral 146
Max. time resol. vs board (Qin=50 fC)
ns
Board in ascending run number/100 order
Max. time resol.
Boards
ns
Entries 146
Mean 1.115
RMS 0.0496
Underflow 0
Overflow 0
Integral 146


CSC AFEB Test at CERN, June 2009. Runs 2161-2237
Av. time resol. vs board (Qin=100 fC)
ns
Board in ascending run number/100 order
Av. time resol.
Boards
ns
Entries 146
Mean 0.6674
RMS 0.02054
Underflow 0
Overflow 0
Integral 146
Max. time resol. vs board (Qin=100 fC)
ns
Board in ascending run number/100 order
Max. time resol.
Boards
ns
Entries 146
Mean 0.7568
RMS 0.02627
Underflow 0
Overflow 0
Integral 146


CSC AFEB Test at CERN, June 2009. Runs 2161-2237
Av. time resol. vs board (Qin=150 fC)
ns
Board in ascending run number/100 order
Av. time resol.
Boards
ns
Entries 146
Mean 0.5402
RMS 0.02121
Underflow 0
Overflow 0
Integral 146
Max. time resol. vs board (Qin=150 fC)
ns
Board in ascending run number/100 order
Max. time resol.
Boards
ns
Entries 146
Mean 0.6459
RMS 0.03268
Underflow 0
Overflow 0
Integral 146